**Investigation into Memory Behavior on van der Waals Heterostructure for the Development of Neuromorphic Device Bioelectronics** 



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## Abstract

Neuromorphic computation has been developed using biological behavior as a model for computers for decades. The separated memory and data processing in neuromorphic devices based on traditional von Neumann architecture is not able enough to reach the satisfactory outcome of analog and continuous information processes in the brain. In this study, a van der Waals heterostructural field effect transistor (VH-FET) using graphene (Gr), hexagonal boron nitride (h-BN) and molybdenum disulfide (MoS<sub>2</sub>) was introduced with a high on/off ratio (~  $10^6$ ) and endurance from ~ 50 program/erase cycles. The hysteresis behavior of the VH-FET performed a huge memory window (~120 V) and non-volatile characteristics. Finally, the memory characteristic of VH-FET was applied in order to



where the non-volatile memory property proves its utility as a memory device. With the channel layer thickness control, better performance of the device can be achieved.

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1.John, R.A; Liu, F; et.al. Synergistic Gating of Electro-Iono-Photoactive 2D Chalcogenide Neuristors: Coexistence Touch-Waals heterostructure with self-writing power switch for synaptic simulation. Nano optoelectronics based on a van der